Se	earch No	otes

	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/715,936	FINN ET AL.
	Examiner	Art Unit
_	Hoang V. Nguyen	2821

	SEAR	CHED	
Class	Subclass	Date	Examiner
343	702	2/3/2005	НИ
343	720	2/3/2005	HN
455	90	2/3/2005	HN
455	557	2/3/2005	HN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEA (INCLUDING	RCH NOT SEARCH S	ES Strategy	)
		DATE	EXMR
EAST		2/3/2005	HN
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